

**Search Notes**

Application No.

09/822,295

Examiner

Anne Holleran

Applicant(s)

JALLAL ET AL.

Art Unit

1642

**SEARCHED**

Class	Subclass	Date	Examiner
530	300	8/16/2004	ALH
	350		
	402		
424	192.1		
	193.1		
435	194		
514	2		

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
530	300	8/16/2004	ALH
	350		
	402		

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Discussed with C. Chan sequence alignment of Cheng ref. with reference to definition of percent id in spec.; 102 withdrawn	8/12/2004	ALH
updated STIC search of sequences; aa 49-294 of SEQ ID NO: 2	7/29/2004	ALH
updated search of U.S. Patents	8/16/2004	ALH

**Search Notes (continued)****Application No.**

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